



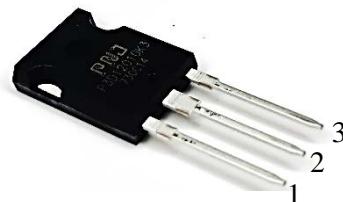
P3M06120K3 SiC MOS N-Channel Enhancement Mode

V_{RRM}	=	650	V
I_D	=	27	A
$I_D(100^\circ\text{C})$	=	19	A
$R_{DS(on)}$	=	120	mΩ

SiC MOS P3M06120K3 N-Channel Enhancement Mode

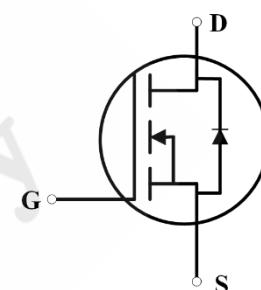
Features

- Qualified to AEC-Q101
- High Blocking Voltage with Low On-Resistance
- High-Frequency Operation
- Ultra-Small Q_{gd}
- 100% UIS tested



Benefits

- Improve System Efficiency
- Increase Power Density
- Reduce Heat Sink Requirements
- Reduction of System Cost



TO-247-3

Gate	1
Drain	2
Source	3

Applications

- Solar Inverters
- EV Battery Chargers
- High Voltage DC/DC Converters
- Switch Mode Power Supplies



Order Information

Part Number	Package	Marking
P3M06120K3	TO-247-3	P3M06120K3



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1. Maximum Ratings

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value	Unit	Test Conditions
Drain - Source Voltage	$V_{DS\max}$	650	V	$V_{GS} = 0\text{V}$ $I_D = 100\mu\text{A}$
Gate - Source Voltage (dynamic)	$V_{GS\max}$	-8 / +20	V	AC ($f > 1 \text{ Hz}$)
Gate - Source Voltage(static) turn-on gate voltage turn-off gate voltage	$V_{GS,\text{on}}$ $V_{GS,\text{off}}$	+15 / +18 -3	V	Static
Continuous Drain Current	I_D	27	A	$V_{GS} = 15\text{V}$ $T_C = 25^\circ\text{C}$
		19		$V_{GS} = 15\text{V}$ $T_C = 100^\circ\text{C}$
Power Dissipation	P_D	131	W	
Operating Junction	T_J	-55 To +175	°C	
Storage Temperature	T_{stg}	-55 To +175	°C	
Solder Temperature	T_L	260	°C	
Mounting Torque	M_d	1 8.8	Nm lbf-in	M3 or 6-32 screw



2. Electrical Characteristics

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ.	Max.		
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	650	/	/	V	$V_{GS} = 0\text{V}$ $I_D = 100\mu\text{A}$
Gate Threshold Voltage	$V_{GS(\text{th})}$	1.8	2.2	/	V	(tested after 30ms pulse at $V_{GS} = 15\text{V}$) $V_{DS} = V_{GS}$ $I_D = 5\text{mA}$ $T_J = 25^\circ\text{C}$
		/	1.65	/	V	$V_{DS} = V_{GS}$ $I_D = 5\text{mA}$ $T_J = 175^\circ\text{C}$
Zero Gate Voltage Drain Current	I_{DSS}	/	1.3	500	μA	$V_{GS} = 0\text{V}$ $V_{DS} = 650\text{V}$
Gate-Source Leakage Current	I_{GSS}	/	2	125	nA	$V_{GS} = 15\text{V}$ $V_{DS} = 0\text{V}$
Drain-Source On-State Resistance	$R_{DS(\text{on})}$	/	120	158	$\text{m}\Omega$	$V_{GS} = 15\text{V}$ $I_D = 10\text{A}$ $T_J = 25^\circ\text{C}$
		/	100	/		$V_{GS} = 18\text{V}$ $I_D = 10\text{A}$ $T_J = 25^\circ\text{C}$
Trans conductance	g_{fs}	/	7	/	S	$V_{DS} = 20\text{V}$ $I_{DS} = 10\text{A}$ $T_J = 25^\circ\text{C}$
		/	6.6	/		$V_{DS} = 20\text{V}$ $I_{DS} = 10\text{A}$ $T_J = 175^\circ\text{C}$



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Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ.	Max.		
Input Capacitance	C_{iss}	/	1200	/	pF	$V_{GS} = 0V$ $V_{DS} = 400V$ $f = 1MHz$ $V_{AC} = 25mV$
Output Capacitance	C_{oss}	/	85.6	/		
Reverse Transfer Capacitance	C_{rss}	/	8.6	/		
Coss Stored Energy	E_{oss}	/	14.3	/	μJ	
Turn-on Energy	E_{on}	/	87	/	μJ	$V_{DS} = 400V$ $V_{GS} = -3/15V$ $I_D = 10A$ $R_G = 1\Omega$
Turn-off Energy	E_{off}	/	7	/		
Turn-on Energy	E_{on}	/	77	/	μJ	$V_{DS} = 400V$ $V_{GS} = -3/18V$ $I_D = 10A$ $R_G = 1\Omega$
Turn-off Energy	E_{off}	/	7	/		
Turn-On Delay Time	$t_{d(on)}$	/	14	/	ns	$V_{DS} = 400V$ $V_{GS} = -3/15V$ $I_D = 10A$ $R_G = 1\Omega$
Rise Time	t_r	/	20	/		
Turn-Off Delay Time	$t_{d(off)}$	/	20	/		
Fall Time	t_f	/	16	/		
Internal Gate Resistance	$R_{G(int)}$	/	1.3	/	Ω	$f = 1MHz$ $V_{AC} = 25mV$
Gate to Source Charge	Q_{gs}	/	9.8	/	nC	$V_{DS} = 400V$ $I_{DS} = 10A$ $V_{GS} = -3 \text{ to } 15V$ $I_G = 20mA$
Gate to Drain Charge	Q_{gd}	/	8.5	/		
Total Gate Charge	Q_g	/	31.6	/		



3. Reverse Diode Characteristics

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value		Unit	Test Conditions
		Typ.	Max.		
Diode Forward Voltage	V_{SD}	4.8	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 5\text{A}$ $T_J = 25^\circ\text{C}$
		4.2	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 5\text{A}$ $T_J = 175^\circ\text{C}$
Continuous Diode Forward Current	I_S	20	/	A	$V_{GS} = -3\text{V}$
Reverse Recover Time	t_{rr}	25	/	ns	$V_{GS} = -3\text{V}$ $I_{SD} = 10\text{A}$ $V_R = 400\text{V}$ $d_i/dt = 3000\text{A}/\mu\text{s}$ $T_J = 25^\circ\text{C}$
Reverse Recovery Charge	Q_{rr}	193	/	nC	
Peak Reverse Recovery Current	I_{rrm}	15	/	A	$V_{GS} = -3\text{V}$ $I_{SD} = 10\text{A}$ $V_R = 400\text{V}$ $d_i/dt = 4000\text{A}/\mu\text{s}$ $T_J = 25^\circ\text{C}$
Reverse Recover Time	t_{rr}	19	/	ns	
Reverse Recovery Charge	Q_{rr}	206	/	nC	$V_{GS} = -3\text{V}$ $I_{SD} = 10\text{A}$ $V_R = 400\text{V}$ $d_i/dt = 4000\text{A}/\mu\text{s}$ $T_J = 25^\circ\text{C}$
Peak Reverse Recovery Current	I_{rrm}	20	/	A	

4. Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction to Case	$R_{\theta JC}$	1.14	°C/W



5. Typical Performance

At $T_J = 25^\circ\text{C}$, unless specified otherwise

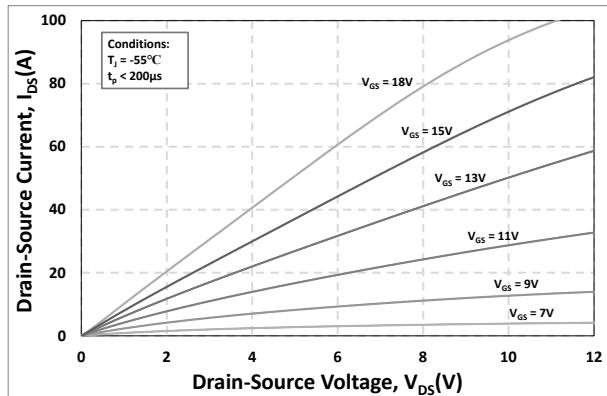


Figure 1. Output Characteristics $T_J = -55^\circ\text{C}$

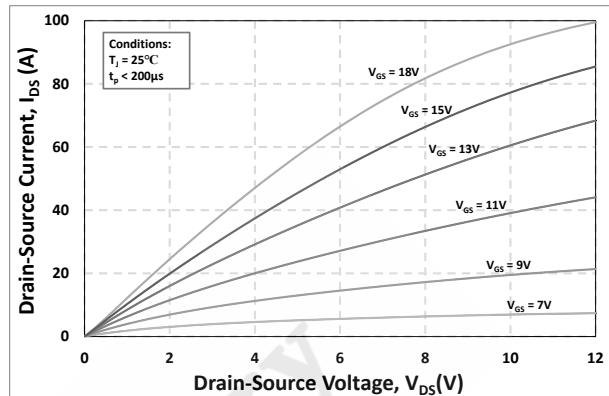


Figure 2. Output Characteristics $T_J = 25^\circ\text{C}$

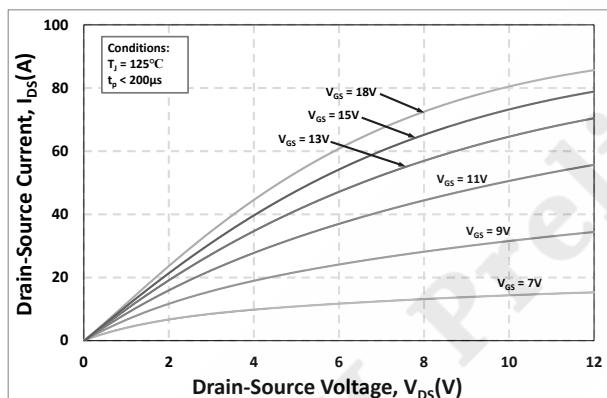


Figure 3. Output Characteristics $T_J = 125^\circ\text{C}$

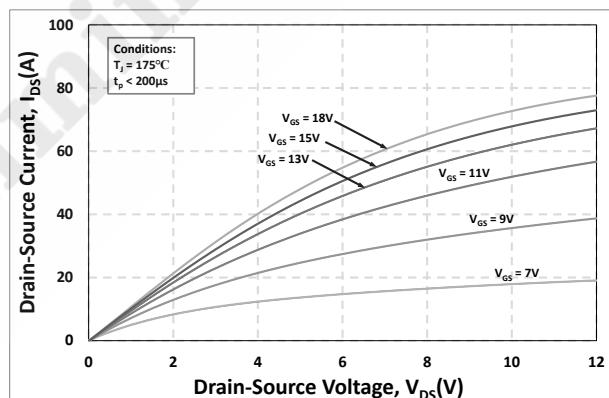


Figure 4. Output Characteristics $T_J = 175^\circ\text{C}$

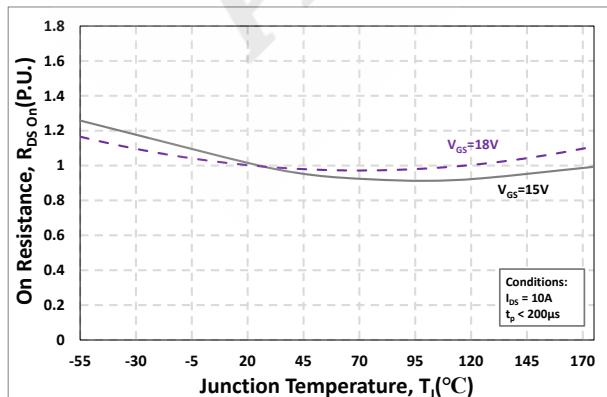


Figure 5. Normalized On-Resistance vs. Temperature

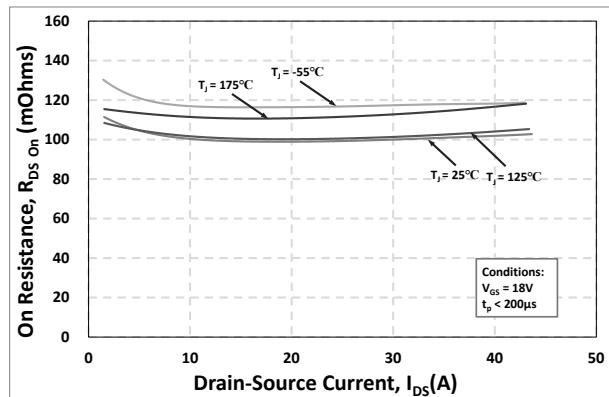


Figure 6. On-Resistance vs. Drain Current Various Temperatures



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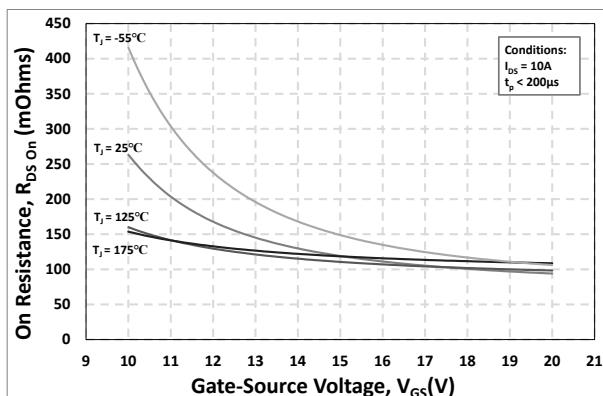


Figure 7. On-Resistance vs. Gate-Source Voltage

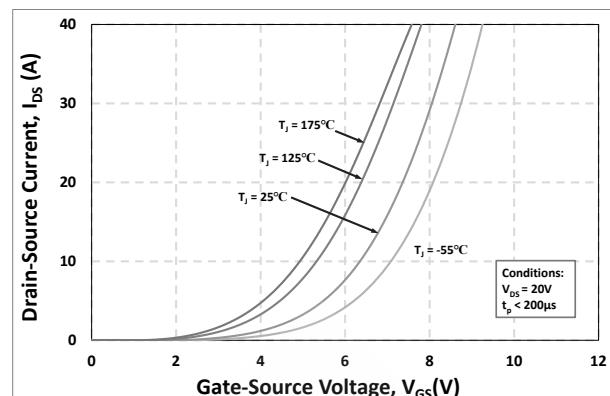


Figure 8. Transfer Characteristic for Various Junction Temperatures

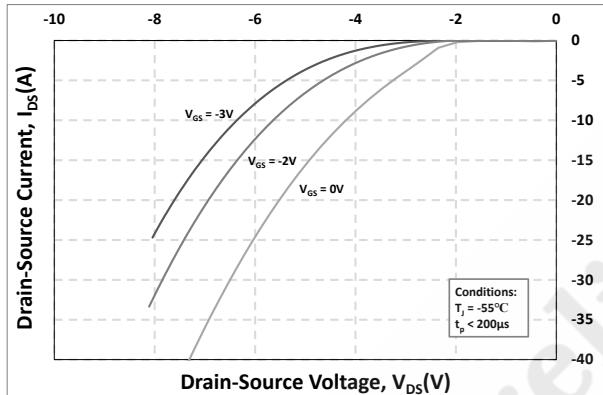


Figure 9. Body Diode Characteristic at -55°C

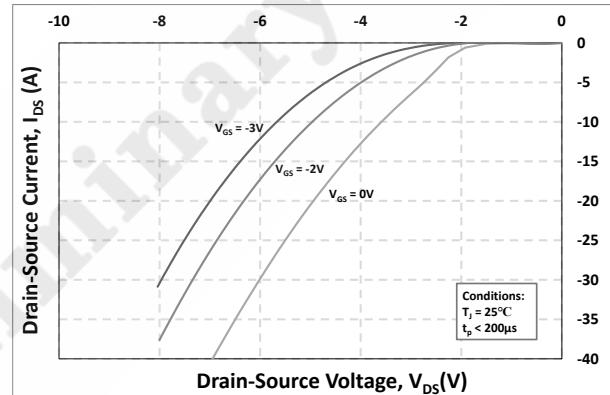


Figure 10. Body Diode Characteristic at 25°C

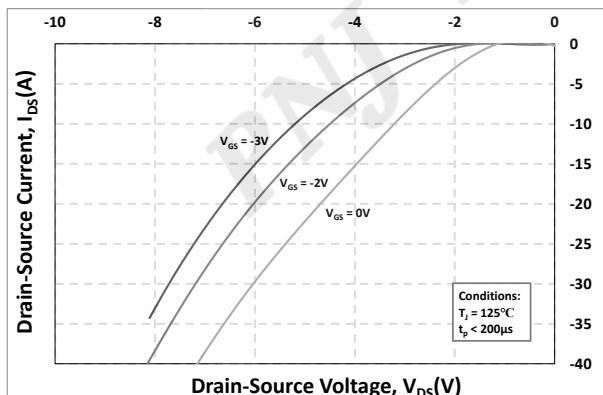


Figure 11. Body Diode Characteristic at 125°C

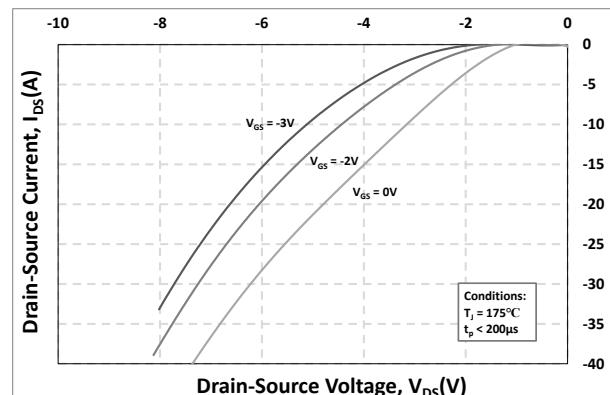


Figure 12. Body Diode Characteristic at 175°C



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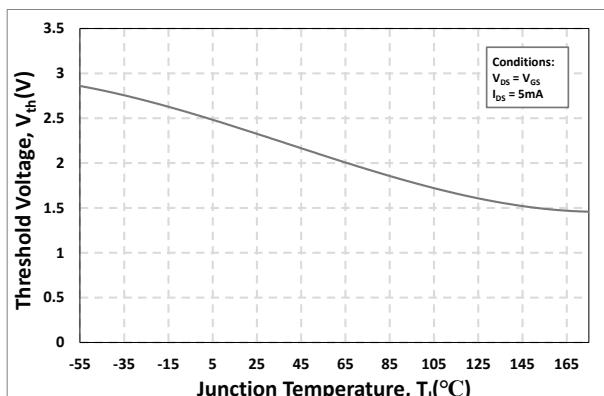


Figure 13. Threshold Voltage vs. Temperature

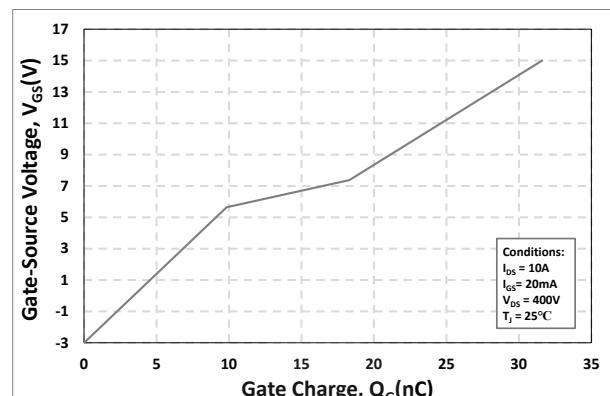


Figure 14. Gate Charge Characteristics

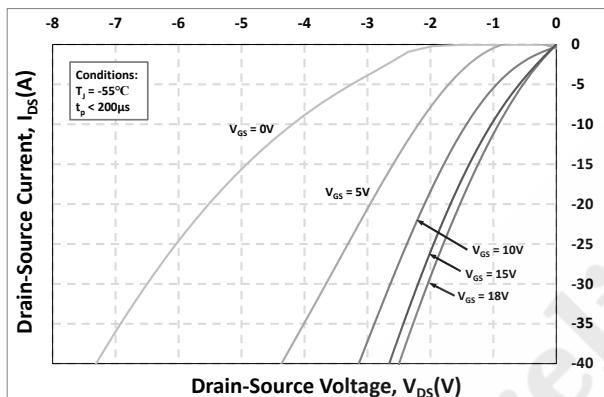


Figure 15. 3rd Quadrant Characteristic at -55°C

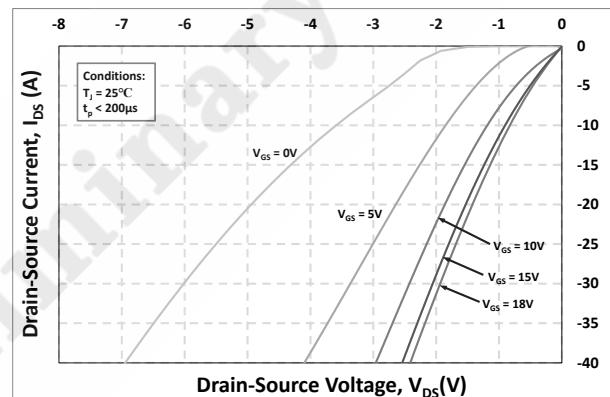


Figure 16. 3rd Quadrant Characteristic at 25°C

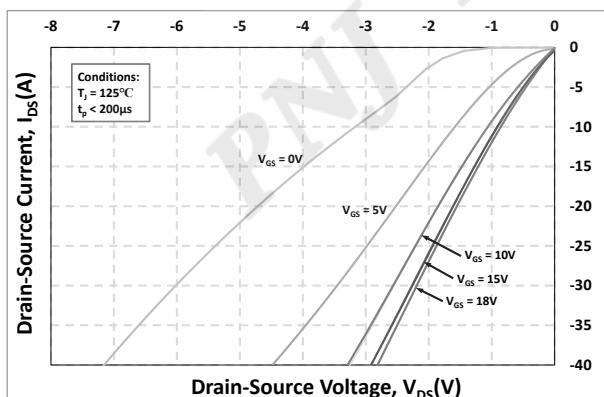


Figure 17. 3rd Quadrant Characteristic at 125°C

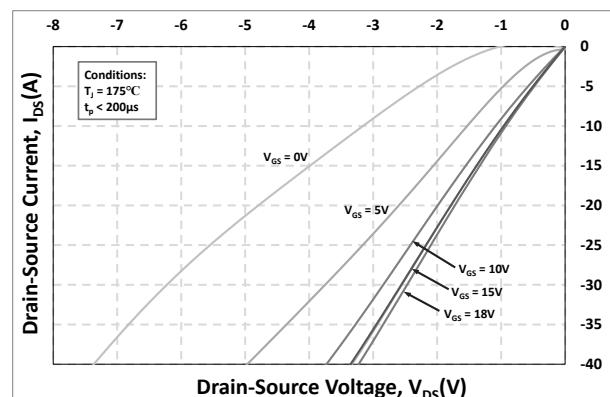


Figure 18. 3rd Quadrant Characteristic at 175°C



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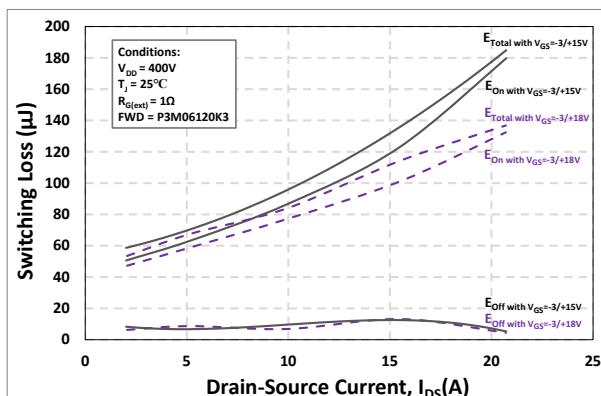


Figure 19. Clamped Inductive Switching Energy vs.
Drain Current ($V_{DD} = 400\text{V}$)

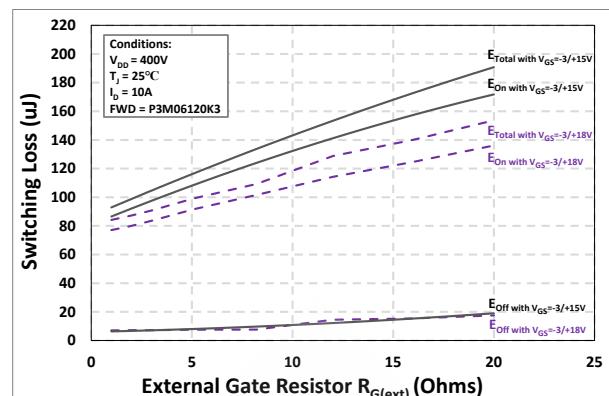


Figure 20. Clamped Inductive Switching Energy vs.
 $R_{G(ext)}$

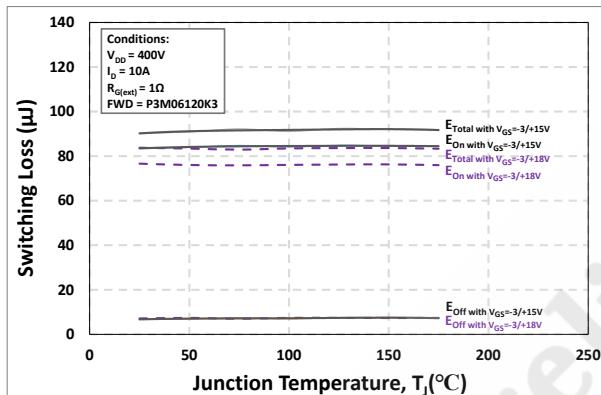


Figure 21. Clamped Inductive Switching Energy vs.
Temperature

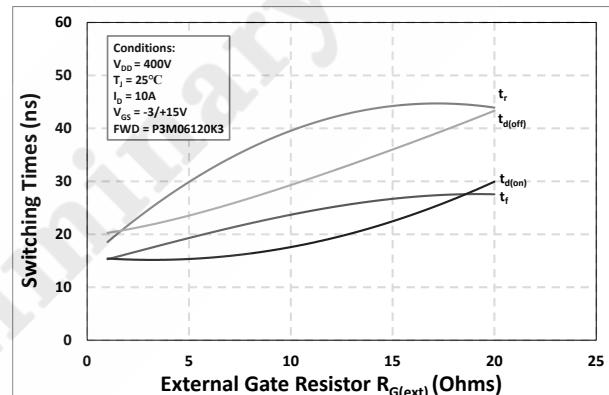


Figure 22. Switching Times vs. $R_{G(ext)}$

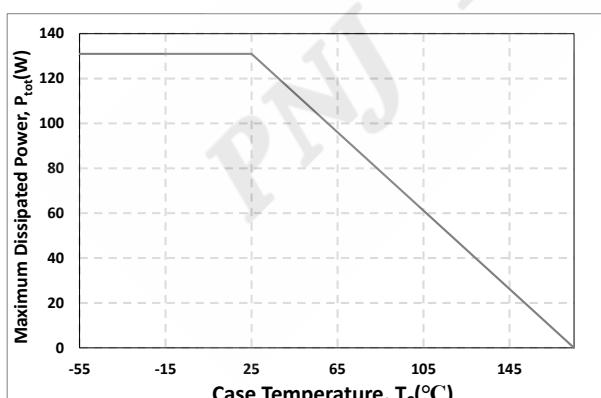


Figure 23. Maximum Power Dissipation Derating vs.
Case Temperature

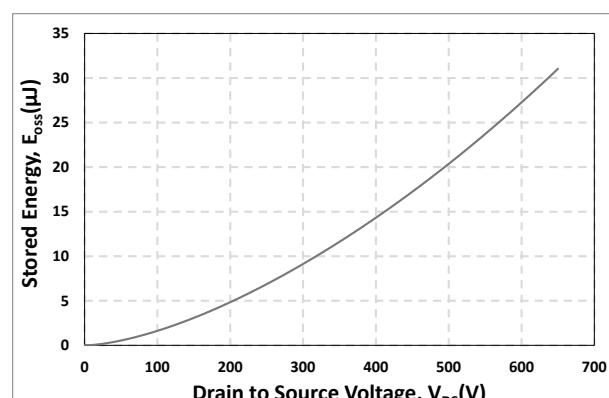
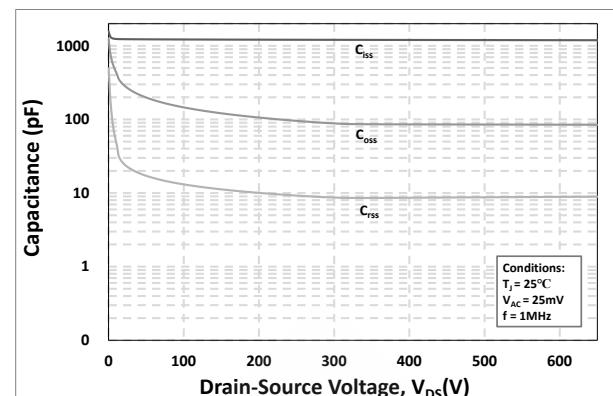
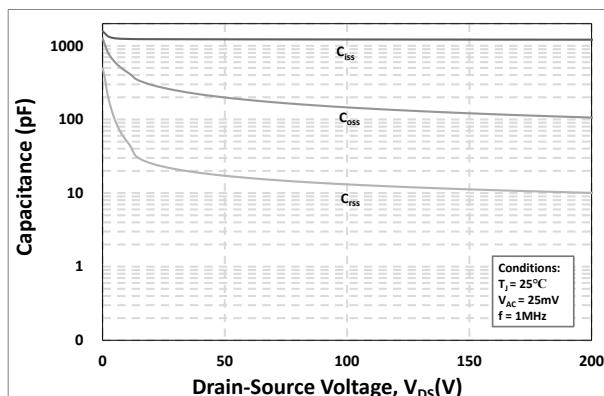


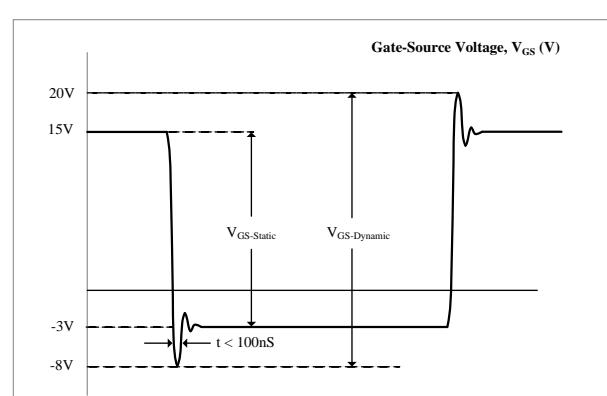
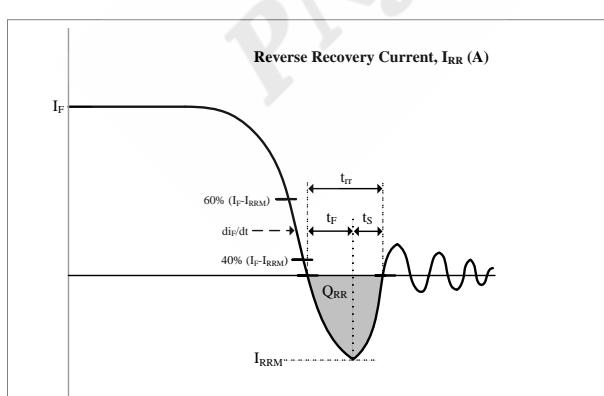
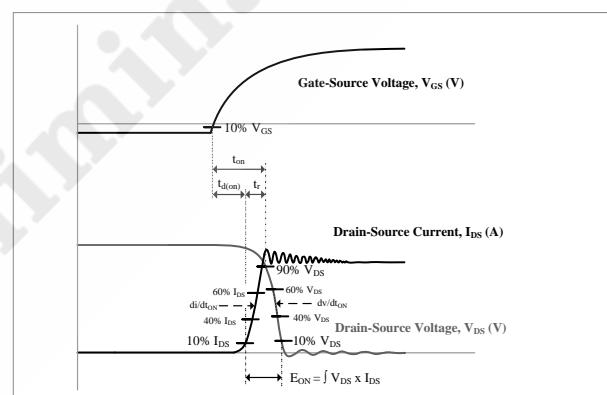
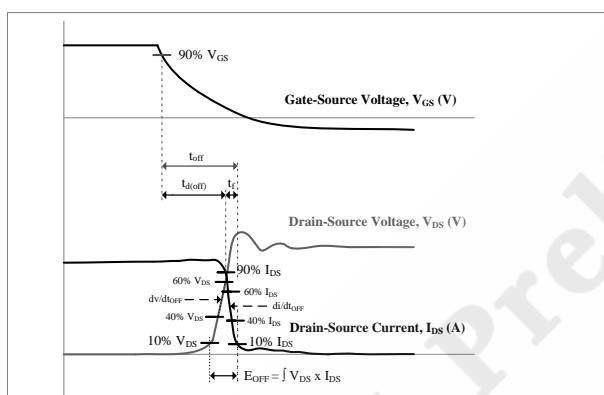
Figure 24. Output Capacitor Stored Energy

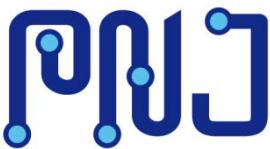


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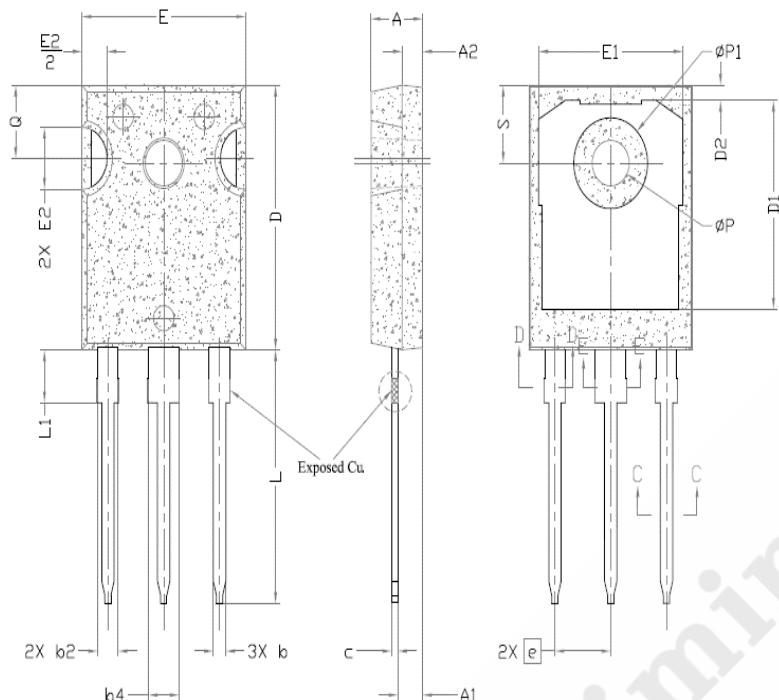


6. Definitions





7. Package Outlines



SYMBOL	DIMENSIONS			NOTES
	MIN.	NOM.	MAX.	
A	4.83	5.02	5.21	
A1	2,29	2,41	2,55	
A2	1,50	2,00	2,49	
b	1,12	1,20	1,33	
b1	1,12	1,20	1,28	
b2	1,91	2,00	2,39	6
b3	1,91	2,00	2,34	
b4	2,87	3,00	3,22	6, 8
b5	2,87	3,00	3,18	
c	0,55	0,60	0,69	6
c1	0,55	0,60	0,65	
D	20,80	20,95	21,10	4
D1	16,25	16,55	17,65	5
D2	0,51	1,19	1,35	
E	15,75	15,94	16,13	4
E1	13,46	14,02	14,16	5
E2	4,32	4,91	5,49	3
e	5,44BSC			
L	19,81	20,07	20,32	
L1	4,10	4,19	4,40	6
ØP	3,56	3,61	3,65	7
ØP1	7,19REF.			
Q	5,39	5,79	6,20	
S	6,04	6,17	6,30	

Drawing and Dimensions



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